

Notice of References Cited	Application/Control No. 10/626,570	Applicant(s)/Patent Under Reexamination OHNO ET AL.	
	Examiner John T. Haran	Art Unit 1733	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,309,485	10-2001	Miyamoto et al.	156/64
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 9740494 A1 /	10-1997	World Intellect	Miyamoto et al.	---
	O	WO 9735720 A1 /	10-1997	World Intellect	KANASHIMA et al.	B32B 31/00
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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